Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/621,657	BENETT ET AL.	
Examiner	Art Unit	
lan M. Ludlow	17/13	

SEARCHED					
Class	Subclass	Date	Examiner		
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	864.17	3/19/2006	JML		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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EAST; inventor search in eDAN	3/19/2006	JML	
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